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(54) DELAY GENERATOR

- 8,004,337 B2 * 8/2011 Brannen 327,264 (75) Inventors: He-Gong Wei, Macau (CN); U-Fat al Chio, Macau (CN); Sai-Weng Sin,
Macau (CN); Seng-Pan U, Macau (CN);
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Macau (CN); Seng-Pan U, Macau (CN); He-Gong Wei, U-Fat Chio, Sai-Weng Sin, Seng-Pan U, Rui Paulo da Rilva Martins, Macau Silva Martins, "A Process-insensitive Current-Controlled Delay (CN) Generator with Threshold Voltage Compensation." in Proc. of IEEE (73) Assignee: University of Macau, Macau (CN) Asian Solid-State Circuits Conference—ASSCC 2010, pp. 1-4,

(21) Appl. No.: $13/289,229$

(22) Filed: Nov. 4, 2011 *Primary Examiner* — An Luu (22) Filed: Nov. 4, 2011 (74) Attorney, Agent, or Firm — Bacon & Thomas, PLLC (65)

US 2012/0286840 A1 Nov. 15, 2012 (57) ABSTRACT

(30) **Foreign Application Priority Data** A delay generator comprises: a current source for supplying a current; a first delay portion, connected to the current source, May 9, 2011 (TW) 100116148 A comprising at least a plurality of inverters and a first capacitor (51) Int. Cl. having a first capacitance; and a second delay portion, con-
 $\overline{H}03H11/06$ (2006.01) having a first capacitance; and a second delay portion, con-HO3H 11/06 (2006.01) nected to the current source, comprising at least a plurality of U.S. Cl. (52) U.S. Cl. inverters and a second capacitor having a second capacitance, wherein the first canacitance is the same as the second capaci USPC 327/276; 327/278; 327/284; 327/285 t hereinth tdel rti tes a first d b tance, wherein the first delay portion generates a first delay by $\frac{327}{327}$ discharging of the first capacitor, wherein the second delay
 $\frac{327}{29}$ $\frac{297}{29}$ discharging of the second delay by charging of the second capacitor, and wherein the total delay generated by the delay (56) **References Cited** generator is obtained by summation of the first delay and the second delay.

4 Claims, 5 Drawing Sheets

200

Fig. 1a

Fig. 1b

 $Fig. 2$

Fig. 3

Fig. 4

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DELAY GENERATOR

BACKGROUND OF THE INVENTION

The present invention relates to a delay generator. More ⁵ particularly, it relates to a process-insensitive current-con trolled delay generator with threshold Voltage compensation.

DESCRIPTION OF THE RELATED ART

Sampled-data systems incorporating data conversion and switched-capacitor filters are indispensable in state-of-art IC design, and are crucial for applications such as telecommu nication, consumer electronics and medical imaging. In Such discrete-time systems, the clock generator is extremely 15 important, and the accuracy of the clock signal is determinant in the overall design since it often affects the overall resolu tion. However, the variation of the clock pulse width exists inevitably and is normally associated with process or tem perature variations in the delay paths. Usually, large design 20 margins should be adopted in the transistor implementation to overcome such process variations. Unfortunately, this would imply extra power consumption with the subsequent degradation of system performance.

Therefore, process-insensitive delay generators are highly 25 demanded and effective solutions have been proposed either

Traditionally, the delay generator is implemented by the inverter-chain, also referred to as g_m/C circuit that accumulates the time delay of the inverters and provides the time 30 delay for the system. Although its architecture is quite simple, it suffers from a significant process variation sensitivity that can lead to a significant $\pm 15\%$ variation in time delay.

An alternative solution, the current-controlled delay gen erator was previously proposed to achieve higher process- 35 insensitivity with the utilization of less process-sensitive cir cuit elements. FIG. 1a schematically illustrates a simplified delay generator which contains basically a current source, a capacitor, switches, and output buffers; and FIG. 1b illustrates input and output waveforms of the delay generator of 40 FIG. 1a. The top-plate of the capacitor C is firstly charged to the voltage supply VDD and Φ_{out} remains at HIGH level. Then, the capacitor C is linearly discharged by a constant current I_b which is controlled by the current source, and thus a delay t_d is generated. 45

To calculate the delay t_d , firstly refer to the following equation:

$$
i = C \frac{dV_C}{dt} \tag{1} \tag{3}
$$

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Under a linear situation, dt $\approx \Delta t$ and dV $\approx \Delta V_c$, thus when $i=I_b$; we obtain

$$
\Delta t = C \frac{\Delta V_C}{I_b} = t_d \tag{2}
$$

where ΔV_c is equal to VDD-V_{th} (V_{th} is the threshold voltage of the inverter connected to Vc).

The current I_b is provided by the current source and its accuracy is mainly related to the precision of the current mirror and the reference current. This is usually accurate and 65 the current mirror is relatively easy to design with good matching. Therefore, the current will not be significantly

affected by process variations. Besides, a MOS-capacitor is adopted to ensure less sensitivity to process variations, when compared with other type of implementations of the capaci tors. Normally, the MOS-capacitance varies around $\pm 5\%$ with process.

However, the delay generator of FIG. $1a$ is still sensitive to process variations, mainly because of threshold Voltage varia tion of the inverter connected to the capacitor. When V_c decreases, the inverter will be triggered to generate the delay

 t_d until V_c passes its threshold voltage V_{th} that depends on the robustness of the N/PMOS transistors and is highly process sensitive.

SUMMARY OF INVENTION

In view of the above, it is an object of the present invention
to provide an advanced current-controlled delay generator using process-insensitive components such as current mirrors and MOS-capacitors, thereby avoiding the complexity of a delay-locked loop (DLL). By applying the threshold voltage compensation, the delay generator of the present invention reduces the deviation induced by the internal inverter buffer, and thus becomes more robust to process variations than prior art.

According to an aspect of the present invention, a delay generator comprises: a current source for Supplying a current; a first delay portion, connected to the current source, comprising at least a plurality of inverters and a first capacitor having a first capacitance; and a second delay portion, connected to the current source, comprising at least a plurality of inverters and a second capacitor having a second capacitance, wherein the first capacitance is the same as the second capaci tance, wherein the first delay portion generates a first delay by portion generates a second delay by charging of the second capacitor, and wherein the total delay generated by the delay generator is obtained by Summation of the first delay and the second delay.

According to the above aspect of the present invention, the total delay is determined by the current and the first capaci tance.

According to the above aspect of the present invention, the first delay portion further comprises two switches that will be tamed on by opposite input clocks.

According to the above aspect of the present invention, the second delay portion further comprises two switches that will be turned on by opposite input clocks.

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects, features and advantages of the present invention will become more apparent from the fol lowing description when taken in conjunction with the accompanying drawings.

FIG. 1a shows a simplified diagram of a delay generator according to prior art.

FIG.1b illustrates input and output waveforms of the delay generator of FIG. 1a.

60 ing to the present invention. FIG. 2 shows a block diagram of a delay generator accord

FIG. 3 illustrates input and output waveforms of the delay generator according to the present invention.

FIG. 4 shows the circuit implementation of the delaygen

erator according to the present invention.
FIG. 5a shows the characteristic waveforms for a first delay portion of the delay generator according to the present invention.

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FIG. 5b shows the characteristic waveforms for a second delay portion of the delay generator according to the present invention.

FIGS. 6a and 6b show characteristic waveforms of the delay generator according to the present invention in a typical ⁵ case and two extreme cases.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

A preferred embodiment for a delay generator according to the invention is described with reference to the drawings as follows.

Refer firstly to FIG. 2, which illustrates an embodiment of a current-controlled delay generator 200 according to the invention. In this embodiment, the delay generator 200 com prises a current source 210, a first delay portion 220 and a second delay portion 230. The current source 210 provides a current I_b to both the first delay portion 220 and the second $_{20}$ delay portion 230. An input clock Φ_{in} in is fed into the first delay portion 220 and an output clock Φ_{middle} having a delay t_{d1} with respect to the clock Φ_{in} is generated. Next, the clock Φ_{middle} is fed into the second delay portion 230 and an output clock Φ_{out} having a delay t_{d2} with respect to the clock Φ_{middle} 25 is generated. As a result, the total delay t_{dtotal} generated by the delay generator 200 is obtained as $t_{d1} + t_{d2}$. A schematic diagram showing the total delay $t_{dtotal} = t_{d1} + t_{d2}$ is shown in FIG. 3. The total delay t_{dtotal} generated by the delay generator 200 is insensitive to the process variation because the process variation incurred when t_{d1} is generated and the process variation incurred when t_{d2} is generated will be compensated by each other. A further detail for achieving the compensation effect of the process variation according to the present inven tion is described as follows. 30 35

The circuit of FIG. 4 represents a preferred embodiment of the delay generator 200. As shown in the figure, the delay generator 200 is comprised of the first delay portion 220 and the second delay portion 230 . Although, in FIG. 4, the current $_{40}$ source 210 is shown as included in the first delay portion 220, the current I_b is also provided to the second delay portion 230 through the bias point Vbn.

The operation of the first delay portion 220 can be divided into two phases. At the first phase, the clock Φ_{in} is going from 45 LOW to HIGH, the switch S1 is open (turned off) and the switch S2 is closed (turned on). Accordingly, a transient current will charge a capacitor C1 until the top-plate voltage V_{C1} of the capacitor C1 reaches VDD. Next, at the second phase, the clock Φ_{in} is going from HIGH to LOW, the switch S1 is closed (turned on) and the switch S2 is open (turned off). Because V_{C1} has been charged to VDD, the voltage V_{tr1} (which is obtained from V_{C1} after two inverters) will be VDD, too. Thus, M3 connects and a discharging current begins to flow. The current mirror comprised of M1 and M2 renders the discharging current equal to I_b . The charge stored on the top plate of the capacitor C1 flows to the ground through S1, M3 and M2, and thus the voltage V_{C_1} starts dropping. When V_{C_1} reaches the threshold voltage V_{th} (triggering point) of the inverter, V_{tr1} becomes digital '0' and thus shuts off M3. At this moment, the discharging current stops flowing from C1 and V_{C1} remains the same. The above discharging operation generates a delay t_{d1} , and thus the clack Φ_{middle} is output, as clearly illustrated in FIG. 5a. Subsequently, the operation returns to the first phase, V_{C1} will be charged to VDD again and V_{tr} also goes to VDD by rapid pull-up of the inverter. 50 55 60 65

As shown in FIG. $5a$, V_{C1} is dropping linearly. Accordingly, by referring to the above-mentioned equation (2), t_{d1} can be expressed as:

$$
t_{d1} = C1 \frac{V_{th} - VDD}{-I_b} \tag{3}
$$

Similarly, the operation of the second delay portion 230 can be divided into two phases. For the second delay portion 230, the clock Φ_{middle} is inverted and used as an input clock. At the first phase, the clock $\overline{\Phi}_{middl}$ is going from HIGH to LOW, the switch S3 is open (turned off) and the switch S4 is closed (turned on). Accordingly, C2, which has a capacitance as the same as that of C1, will be discharged through the switch S4 and reset to ground. Next, at the second phase, the clock $\overline{\Phi}_{middle}$ is going from LOW to HIGH, the switch S3 is closed (turned on) and the switch S4 is open (turned off). Accordingly, C2 is charged by a constant current from a p-type current mirror comprised of M6 and M7, and the voltage V $_{C_2}$ starts raising from 0 (ground). When V $_{C_2}$ reaches the threshold voltage V_{th} (triggering point) of the inverter, $V_{1/2}$ becomes digital '0' and thus shuts off M8. At this moment, the charging current stops flowing to C2 and V_{C2} remains the same. The above charging operation generates a delay t_{d2} , and thus the clock Φ_{out} is output, as clearly illustrated in FIG. 5b.

As shown in FIG. $5b$, V_{C2} is raising linearly. Again, by referring to the above-mentioned equation (2), t_{td2} can be expressed as:

$$
q_2 = C2 \frac{V_{th} - 0}{I_b} \tag{4}
$$

As mentioned above, the total delay t_{dtotal} generated by the delay generator 200 is obtained by summation of t_{d1} and t_{d2} , that is, $t_{d1} + t_{d2}$. From equations (3) and (4), we obtain:

 t_{c}

$$
t_{dtotal} = \frac{(C1 - C2)V_{th} + C1 \times VDD}{I_b}
$$
 (5)

As C1=C2, it leads to,

$$
t_{dtotal} = \frac{C1 \times VDD}{I_b} \tag{6}
$$

Since C1, VDD and I_b are all preset values, t_{dtotal} will be a constant. In other words, the total delay $\boldsymbol{\mathrm{t}}_{dtotal}$ is not affected by the threshold voltage V_{th} , which is highly process-sensitive

To further explain the threshold voltage compensation applied by the present invention, refer now to FIGS. $6a$ and $6b$, wherein characteristic waveforms of the delay generator according to the present invention are illustrated in a typical case ('tt') and two extreme cases ('fs': fast NMOS and slow PMOS, 'sf': slow NMOS and fast PMOS). The two extreme cases are provided as examples of process corners which will produce most significant drifts in the threshold voltage V_{ab} . As shown in the figures, waveforms similar to those of FIG. 5*a* and 5*b* can be observed for the typical case (process corner 't'). For the 'fs' process corner, a shorter $t_{d1,s}$ and a longer $t_{d2,fs}$ can be observed For the 'sf' process corner, a longer $t_{d1,sf}$ and a shorter $t_{d2,sf}$ can be observed. However, both the summation of $t_{d1,sf}$ and $t_{d2,sf}$ will lead to the same total delay t_{dtotal} as that of the typical process corner 'tt'. In other words, the shorter $t_{d1,sf}$ i process corner tt. In other words, the shorter $t_{d1,gs}$ is "compensated" by the longer $t_{d2,gs}$ and the longer $t_{d1,gs}$ is "compensated" by the shorter $t_{d2,sf}$ I his is not difficult to derive because, according to the above equation (6), the same total delay t_{dtotal} will be obtained for either the f is process corner or the sf process corner.

While the present invention has been described with reference to a preferred embodiment, it will be understood by those skilled in the art that various changes may be made and equivalents may be substituted for elements thereof without departing from the scope of the invention. Therefore, it is intended that the invention will include all embodiments fall ing within the scope of the appended claims. 10 15

The invention claimed is:

1. A delay generator, comprising:

- a first delay portion comprising at least a plurality of invert ers and a first capacitor having a first capacitance; and
- a second delay portion comprising at least a plurality o inverters and a second capacitor having a second capaci tance;
- $\frac{6}{100}$ a current source for providing a current to the first delay portion and the second delay portion,
- wherein the first capacitance is the same as the second capacitance,
- wherein the first delay portion generates a first delay by discharging of the first capacitor,
- wherein the second delay portion generates a second delay by charging of the second capacitor, and
- wherein the total delay generated by the delay generator is obtained by summation of the first delay and the second delay.

2. The delay generator according to claim 1, wherein the total delay is determined by the current and the first capaci tance.

3. The delay generator according to claim 1, wherein the first delay portion further comprises two switches that will be turned on by opposite input clocks.

4. The delay generator according to claim 1, wherein the second delay portion further comprises two switches that will be turned on by opposite input clocks.

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